



JIANGSU CHANGJING ELECTRONICS TECHNOLOGY CO., LTD

## TO-220BK Plastic-Encapsulate Thyristors

### CT308B 3Q TRIACs

#### MAIN CHARACTERISTICS

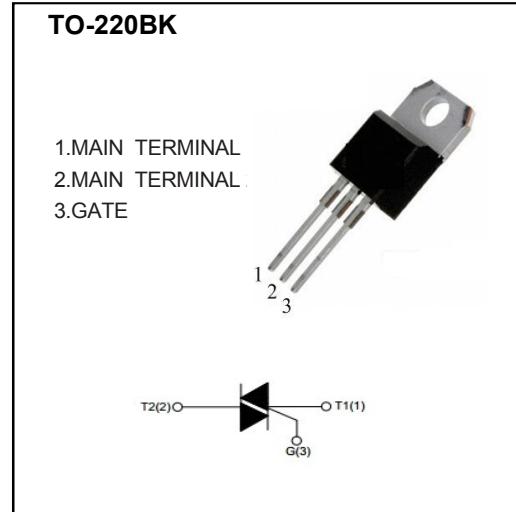
$I_{T(RMS)}$		8A
$V_{DRM}/V_{RRM}$	CT308B-600S/C	600V
	CT308B-800S/C	800V
$V_{TM}$		1.55V

#### FEATURES

- NPNPN 5-layer Structure TRIACs
- Mesa Glass Passivated Technology
- Multi Layers Metal Electrodes
- High Junction Temperature
- Good Commutation Performance
- High dV/dt and dl/dt

#### APPLICATIONS

- Heater Control
- Motor Speed Controller
- Mixer



#### MARKING



CT308B:Series Code  
600S:Depends on  $V_{DRM}$  and  $I_{GT}$   
XXX:Internal Code

#### ABSOLUTE RATINGS ( $T_a=25^\circ\text{C}$ unless otherwise noted )

Symbol	Parameter	Test condition		Value		Unit
$V_{DRM}/ V_{RRM}$	Repetitive peak off-state voltage	$T_j=25^\circ\text{C}$	CT308B-600S/C	600		V
			CT308B-800S/C	800		V
$I_{T(RMS)}$	RMS on-state current	TO-220BK( $T_c \leq 110^\circ\text{C}$ ), Fig. 1,2		8		A
$I_{TSM}$	Non repetitive surge peak on-state current	Full sine wave , $T_j(\text{init})=25^\circ\text{C}$ , tp=20ms; Fig. 3,5		80		A
$I^2t$	$I^2t$ value	tp=10ms		36		$\text{A}^2\text{s}$
$dI_t/dt$	Critical rate of rise of on-state current	$I_G=2*I_{GT}$ , $tr \leq 10\text{ns}$ , $F=120\text{Hz}$ , $T_j=125^\circ\text{C}$		I - II - III	50	$\text{A}/\mu\text{s}$
				IV	n/a	
$I_{GM}$	Peak gate current	tp=20 $\mu\text{s}$ , $T_j=125^\circ\text{C}$		2		A
$P_{G(AV)}$	Average gate power	$T_j=125^\circ\text{C}$		0.5		W
$T_{STG}$	Storage temperature				-40~+150	$^\circ\text{C}$
$T_j$	Operating junction temperature				-40~+125	

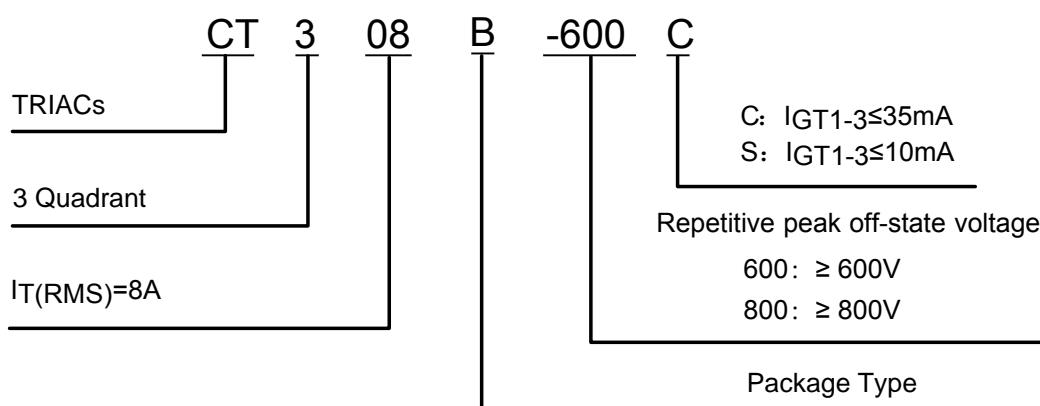
## ELECTRICAL CHARACTERISTICS ( $T_a=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test condition	Value		Unit
			S	C	
$I_{GT}$	Gate trigger current	$V_D=12\text{V}$ , $I_T=0.1\text{A}$ , $T_j=25^\circ\text{C}$ , Fig. 6	$\leq 10$	$\leq 35$	mA
			n/a	n/a	
$V_{GT}$	Gate trigger voltage	$I - \text{II} - \text{III}$	$\leq 1.3$		V
$V_{GD}$	Non-triggering gate voltage	$V_D=V_{DRM}, T_j=125^\circ\text{C}$		$\geq 0.2$	
$I_H$	Holding current	$V_D=12\text{V}$ , $I_{GT}=0.1\text{A}$ , $T_j=25^\circ\text{C}$ , Fig. 6	$\leq 15$	$\leq 25$	mA
$I_L$	Latching current		$\leq 20$	$\leq 30$	mA
			$\leq 25$	$\leq 35$	mA
$dV_D/dt$	Critical rate of rise of off-state	$V_D=67\%V_{DRM}$ , Gate Open $T_j=125^\circ\text{C}$		$\geq 40$	$\geq 80$
$V_{TM}$	On-state Voltage	$I_{TM}=10\text{A}, t_p=380\mu\text{s}$ , Fig. 4		$\leq 1.55$	
$I_{DRM} / I_{RRM}$	Repetitive peak off-state current	$V_D=V_{DRM}/V_{RRM}, T_j=25^\circ\text{C}$	$\leq 5$	$\leq 5$	$\mu\text{A}$
		$V_D=V_{DRM}/V_{RRM}, T_j=125^\circ\text{C}$	$\leq 1$	$\leq 1$	mA

## THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
$R_{th} (j-c)$	Junction to case (AC)	1.6	$^\circ\text{C/W}$
$R_{th} (j-a)$	Junction to ambient	60	$^\circ\text{C/W}$

## PART NUMBER



## CHARACTERISTICS CURVES

FIG.1: Maximum power dissipation versus RMS on-state current (full cycle)

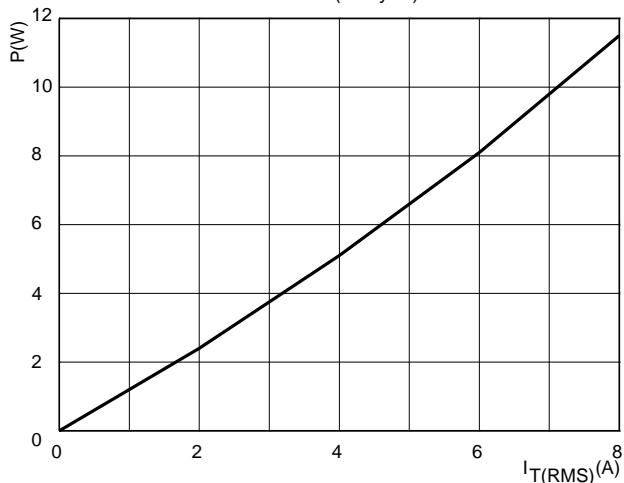


FIG.2: RMS on-state current versus case temperature (full cycle)

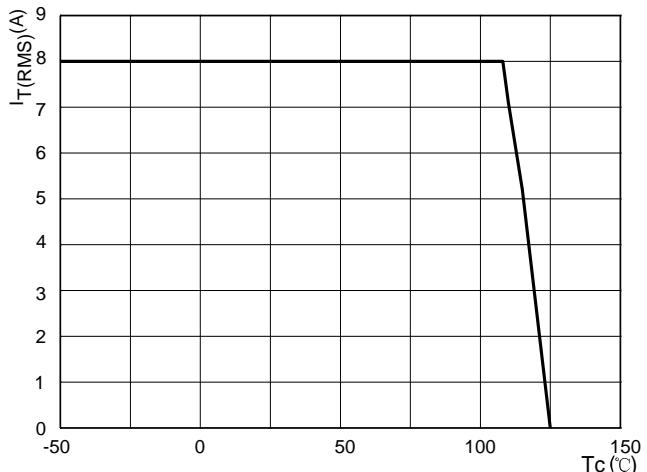


FIG.3: Surge peak on-state current versus number of cycles

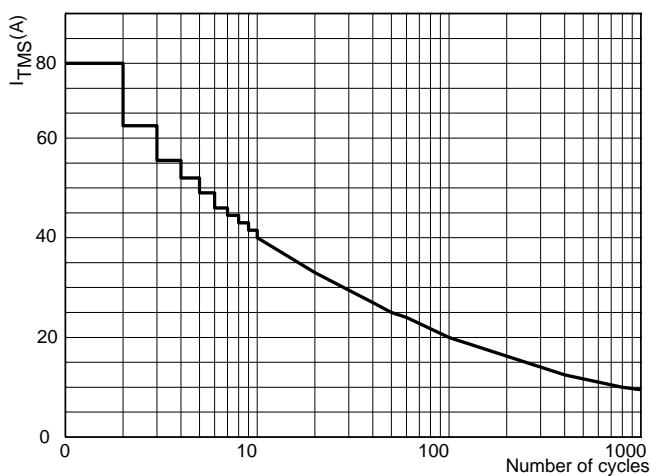


FIG.4: On-state characteristics (maximum values)

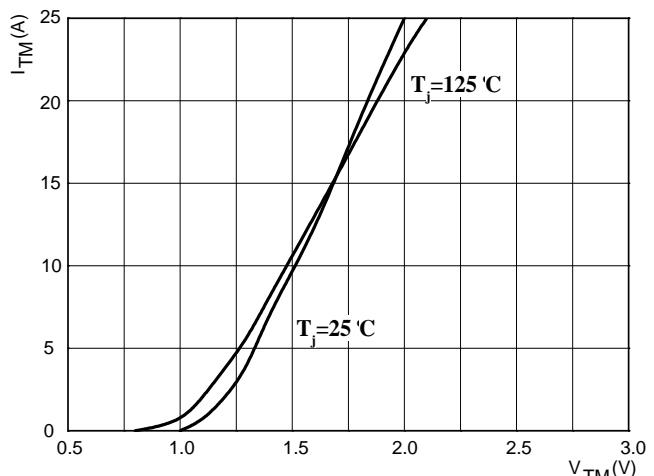


FIG.5: Non-repetitive surge peak on-state current for a sinusoidal pulse with width  $t_p < 10\text{ms}$

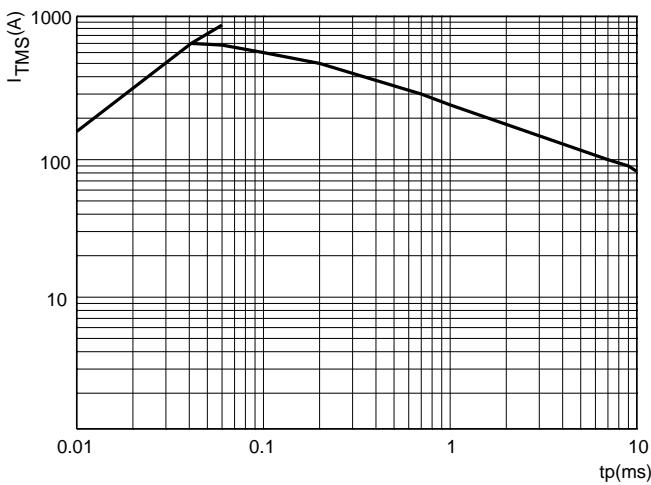
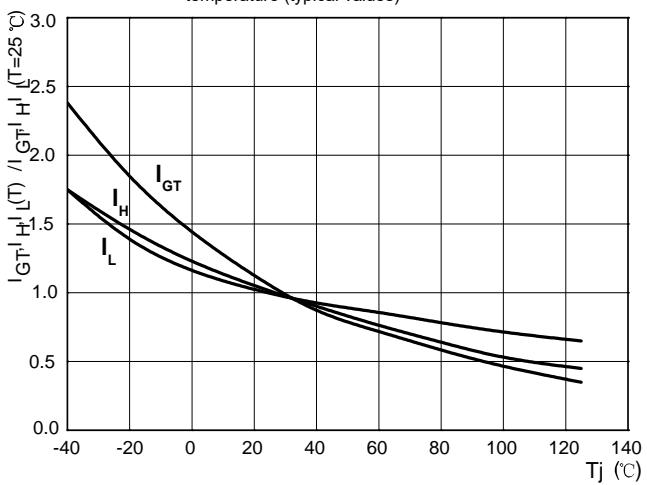
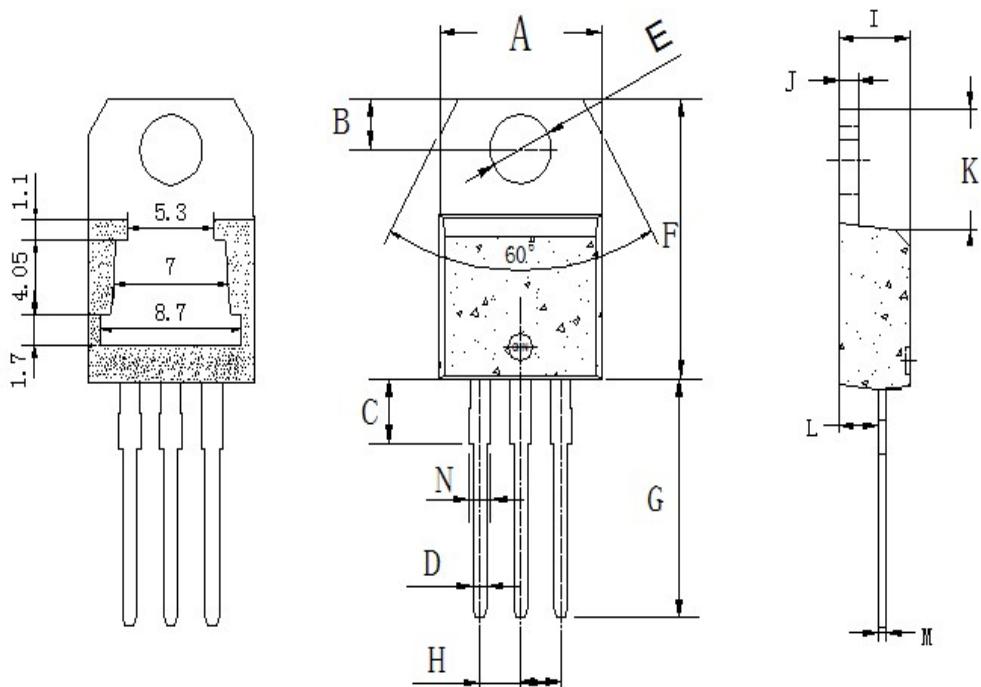


FIG.6: Relative variations of gate trigger current, holding current and latching current versus junction temperature (typical values)



## TO-220BK PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	9.8	10.4	0.385	0.409
B	2.65	3.1	0.104	0.122
C	2.8	4.2	0.110	0.165
D	0.7	0.92	0.027	0.036
E	3.75	3.95	0.147	0.155
F	14.8	16.1	0.582	0.633
G	13.05	13.6	0.513	0.535
H	2.4	2.7	0.094	0.106
I	4.38	4.61	0.172	0.181
J	1.15	1.36	0.045	0.053
K	5.85	6.82	0.230	0.268
L	2.35	2.75	0.092	0.108
M	0.35	0.65	0.013	0.025
N	1.18	1.42	0.046	0.055